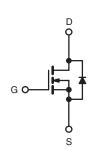


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	60			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V	0.20		
Q _g (Max.) (nC)	11			
Q _{gs} (nC)	3.1			
Q _{gd} (nC)	5.8			
Configuration	Single			





N-Channel MOSFET

FEATURES

- Dynamic dV/dt Rating
- · For Automatic Insertion
- End Stackable
- 175 °C Operating Temperature
- · Fast Switching
- · Ease of Paralleling
- Simple Drive Requirements
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W

ORDERING INFORMATION	
Package	HEXDIP
Load (Dh) free	IRFD014PbF
Lead (Pb)-free	SiHFD014-E3
SnPb	IRFD014
	SiHFD014

ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	60	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	- I _D	1.7	А	
		T _C = 100 °C		1.2		
Pulsed Drain Current ^a			I _{DM}	14		
Linear Derating Factor				0.0083	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	130	mJ	
Maximum Power Dissipation	T _C = 25 °C		P _D	1.3	W	
Peak Diode Recovery dV/dtc			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 52 mH, R_G = 25 Ω , I_{AS} = 1.7 A (see fig. 12).
- c. $I_{SD} \leq$ 10 A, $dI/dt \leq$ 90 A/ μ s, $V_{DD} \leq$ V_{DS} , $T_{J} \leq$ 175 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFD014, SiHFD014

Vishay Siliconix



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R_{thJA}	=	120	°C/W		

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT			
Static					1				
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	60	-	-	V			
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referen	Reference to 25 °C, I _D = 1 mA		0.063	_	V/°C		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} :	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V		
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V		-	± 100	nA		
		V _{DS}	$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150 \text{ °C}$		V _{DS} = 60 V, V _{GS} = 0 V		-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V			-	250	μΑ		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.0 A ^b	-	-	0.20	Ω		
Forward Transconductance	9 _{fs}	V _{DS}	$V_{DS} = 25 \text{ V}, I_D = 1.0 \text{ Ab}$		-	-	S		
Dynamic		,							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	310	-	pF		
Output Capacitance	C _{oss}			-	160	-			
Reverse Transfer Capacitance	C _{rss}			-	37	-			
Total Gate Charge	Qg		I _D = 10 A, V _{DS} = 48 V see fig. 6 and 13 ^b	-	-	11	nC		
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	3.1			
Gate-Drain Charge	Q _{gd}	7	g. c and ro	-	-	5.8			
Turn-On Delay Time	t _{d(on)}	'		-	10	-	- ns		
Rise Time	t _r	Van	V _{DD} = 30 V, I _D = 10 A		50	-			
Turn-Off Delay Time	t _{d(off)}	$R_{\rm G} = 24~\Omega,~R_{\rm D} = 2.7~\Omega,~{\rm see~fig.~}10^{\rm b}$		-	13	-			
Fall Time	t _f			-	19	-			
Internal Drain Inductance	L_{D}	6 mm (0.25")	Between lead, 6 mm (0.25") from		4.0	-	n L		
Internal Source Inductance	L _S	package and center of die contact		-	6.0	-	nH		
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	I _S	MOSFET sym	MOSFET symbol showing the		-	1.7	A		
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	14	^		
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 1.7 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.6	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 10 \text{A}, dI/dt = 100 \text{A/}\mu\text{s}^b$		-	70	140	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.20	0.40	μC		
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

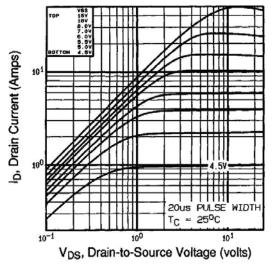
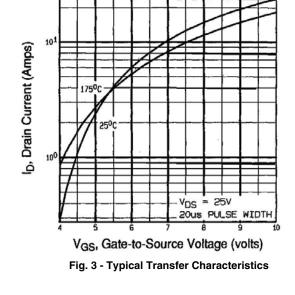


Fig. 1 - Typical Output Characteristics, T_C = 25 °C



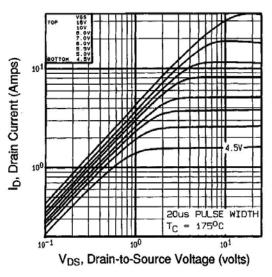


Fig. 2 - Typical Output Characteristics, T_C = 175 °C

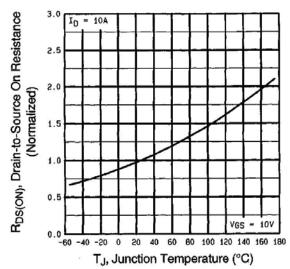


Fig. 4 - Normalized On-Resistance vs. Temperature

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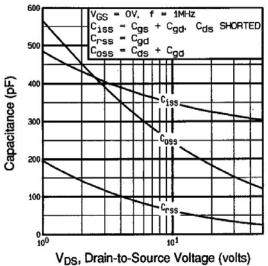


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

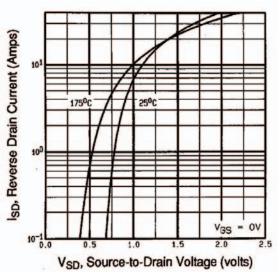


Fig. 7 - Typical Source-Drain Diode Forward Voltage

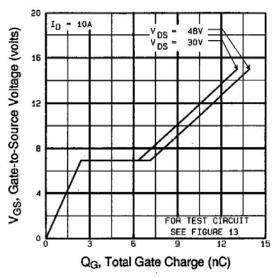


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

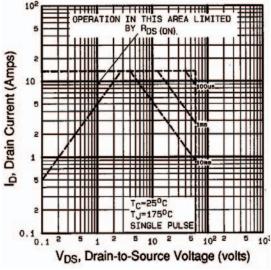


Fig. 8 - Maximum Safe Operating Area





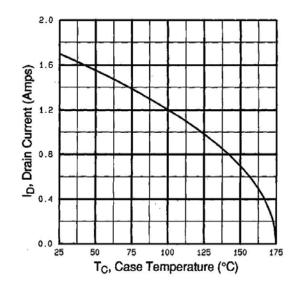


Fig. 9 - Maximum Drain Current vs. Case Temperature

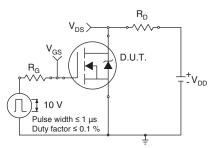


Fig. 10a - Switching Time Test Circuit

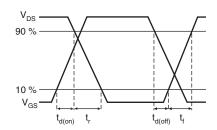


Fig. 10b - Switching Time Waveforms

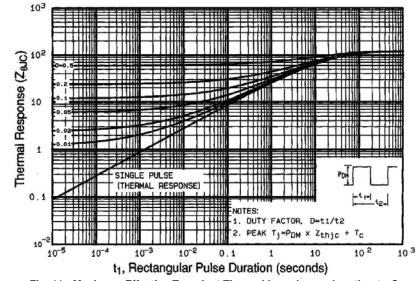


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

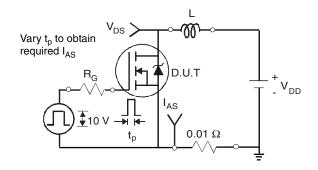


Fig. 12a - Unclamped Inductive Test Circuit

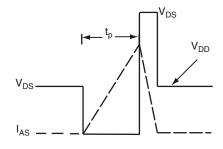


Fig. 12b - Unclamped Inductive Waveforms

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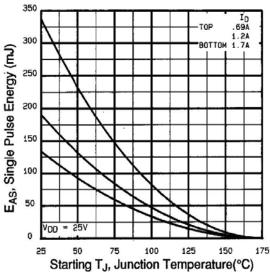


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

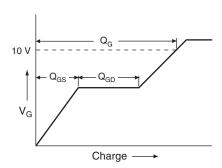


Fig. 13a - Basic Gate Charge Waveform

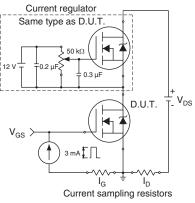
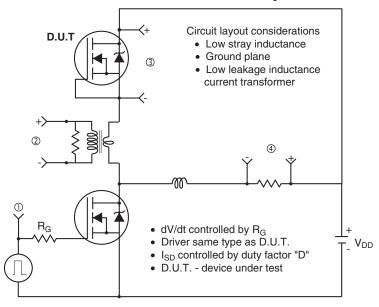
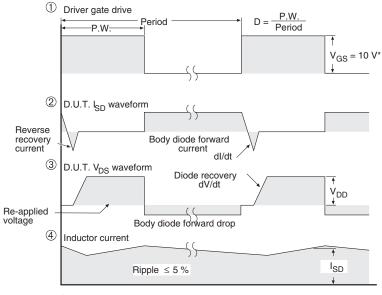


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel

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